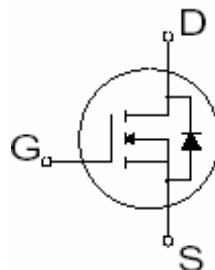


- Extremely high dv/dt capability
- Low Gate Charge Qg results in Simple Drive Requirement
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatability



**V<sub>DSS</sub> = 250V**

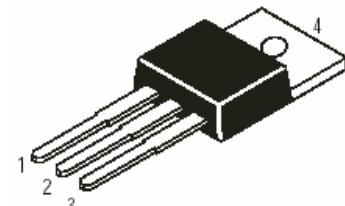
**I<sub>D25</sub> = 14A**

**R<sub>DSON</sub> = 0.28 Ω**

## Description

StarMOS is a new generation of high voltage N-Channel enhancement mode power MOSFETs.

This new technology minimises the JFET effect, increases packing density and reduces the on-resistance. StarMOS also achieves faster switching speeds through optimised gate layout with planar stripe DMOS technology.



Pin1-Gate  
Pin2-Drain  
Pin3-Source

## Application

- Switching application

## Absolute Maximum Ratings

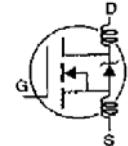
|                                       | Parameter  | Max.                 | Units |
|---------------------------------------|--|----------------------|-------|
| I <sub>D</sub> @T <sub>c</sub> =25°C  | Continuous Drain Current,V <sub>GS</sub> @10V    | 14                   | A     |
| I <sub>D</sub> @T <sub>c</sub> =100°C | Continuous Drain Current,V <sub>GS</sub> @10V    | 8.9                  |       |
| I <sub>DM</sub>                       | Pulsed Drain Current ①                           | 56                   |       |
| P <sub>D</sub> @T <sub>c</sub> =25°C  | Power Dissipation                                | 139                  | W     |
|                                       | Linear Derating Factor                           | 1.1                  | W/°C  |
| V <sub>GS</sub>                       | Gate-to-Source Voltage                           | ±30                  | V     |
| E <sub>AS</sub>                       | Single Pulse Avalanche Energy ②                  | 490                  | mJ    |
| I <sub>AR</sub>                       | Avalanche Current ①                              | 14                   | A     |
| E <sub>AR</sub>                       | Repetitive Avalanche Energy ①                    | 13.9                 | mJ    |
| dv/dt                                 | Peak Diode Recovery dv/dt ③                      | 4.8                  | V/ns  |
| T <sub>J</sub>                        | Operating Junction and Storage Temperature Range | - 55 to +150         |       |
| T <sub>STG</sub>                      | Soldering Temperature, for 10 seconds            | 300(1.6mm from case) |       |
|                                       | Mounting Torque,6-32 or M3 screw                 | 10 lbf.in(1.1N.m)    |       |

## Thermal Resistance

|                  | Parameter                         | Min. | Typ. | Max. | Units |
|------------------|-----------------------------------|------|------|------|-------|
| R <sub>θJC</sub> | Junction-to-case                  | —    | —    | 0.9  | C/W   |
| R <sub>θCS</sub> | Case-to-Sink,Flat,Greased Surface | —    | 0.50 | —    |       |
| R <sub>θJA</sub> | Junction-to-Ambient               | —    | —    | 62.5 |       |

### Electrical Characteristics @TJ=25°C(unless otherwise specified)

|  | Parameter                            | Min. | Typ. | Max. | Units | Test Conditions   |
|--|--------------------------------------|------|------|------|-------|---|
| V <sub>(BR)DSS</sub>                   | Drain-to-Source Breakdown Voltage    | 250  | —    | —    | V     | V <sub>GS</sub> =0V,I <sub>D</sub> =250μA                                     |
| △V <sub>(BR)DSS</sub> /△T <sub>J</sub> | Breakdown Voltage Temp.Coefficient   | —    | 0.28 | —    | V/C   | Reference to 25°C,I <sub>D</sub> =250μA                                       |
| R <sub>DS(on)</sub>                    | Static Drain-to-Source On-resistance | —    | —    | 0.28 | Ω     | V <sub>GS</sub> =10V,I <sub>D</sub> =7A ④                                     |
| V <sub>GS(th)</sub>                    | Gate Threshold Voltage               | 2.0  | —    | 4.0  | V     | V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA                       |
| g <sub>fs</sub>                        | Forward Transconductance             | —    | 8.65 | —    | S     | V <sub>DS</sub> =40V,I <sub>D</sub> =7A                                       |
| I <sub>DSS</sub>                       | Drain-to-Source Leakage current      | —    | —    | 10   | μ A   | V <sub>DS</sub> =250V,V <sub>GS</sub> =0V                                     |
|  |                                      | —    | —    | 100  | μ A   | V <sub>DS</sub> =200V,V <sub>GS</sub> =0V,T <sub>J</sub> =150°C               |
| I <sub>GSS</sub>                       | Gate-to-Source Forward leakage       | —    | —    | 100  | nA    | V <sub>GS</sub> =30V  |
|  | Gate-to-Source Reverse leakage       | —    | —    | -100 | nA    | V <sub>GS</sub> =-30V   |
| Q <sub>g</sub>                         | Total Gate Charge                    | —    | 46   | 61   |       | I <sub>D</sub> =14A   |
| Q <sub>gs</sub>                        | Gate-to-Source charge                | —    | 9.3  | —    |       | nC V <sub>DS</sub> =200V  |
| Q <sub>gd</sub>                        | Gate-to-Drain("Miller") charge       | —    | 19.5 | —    |       | V <sub>GS</sub> =10V  |
| t <sub>d(on)</sub>                     | Turn-on Delay Time                   | —    | 17   | 50   |       | nS V <sub>DD</sub> =125V<br>I <sub>D</sub> =14A<br>R <sub>G</sub> =9.1Ω       |
| t <sub>r</sub>                         | Rise Time                            | —    | 17   | 50   |       |   |
| t <sub>d(off)</sub>                    | Turn-Off Delay Time                  | —    | 74   | 160  |       |   |
| t <sub>f</sub>                         | Fall Time                            | —    | 32   | 80   |       |   |
| L <sub>D</sub>                         | Internal Drain Inductance            | —    | 4.5  | —    | nH    | Between lead,<br>6mm(0.25in.)<br>from package<br>and center of<br>die contact |
| L <sub>s</sub>                         | Internal Source Inductance           | —    | 7.5  | —    |       |   |
| C <sub>iss</sub>                       | Input Capacitance                    | —    | 1230 | 1600 |       | V <sub>GS</sub> =0V   |
| C <sub>oss</sub>                       | Output Capacitance                   | —    | 180  | 65   | pF    | V <sub>DS</sub> =25V  |
| C <sub>rss</sub>                       | Reverse Transfer Capacitance         | —    | 23   | 28   |       | f=1.0MHz  |



### Source-Drain Ratings and Characteristics

|                 | Parameter                                 | Min.  | Typ. | Max. | Units | Test Conditions   |
|-----------------|---|---|------|------|-------|---|
| I <sub>s</sub>  | Continuous Source Current<br>(Body Diode) | —   | —    | 14   | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode. |
| I <sub>SM</sub> | Pulsed Source Current<br>(Body Diode) ①   | —   | —    | 56   |       |   |
| V <sub>SD</sub> | Diode Forward Voltage                     | —   | —    | 1.5  | V     | T <sub>J</sub> =25°C,I <sub>s</sub> =14A,V <sub>GS</sub> =0V ④          |
| t <sub>rr</sub> | Reverse Recovery Time                     | —   | 215  | —    | nS    | T <sub>J</sub> =25°C,I <sub>F</sub> =14A                                |
| Q <sub>rr</sub> | Reverse Recovery Charge                   | —   | 1.59 | —    | μC    | di/dt=100A/μs ④   |
| t <sub>on</sub> | Forward Turn-on Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>s</sub> + L <sub>D</sub> ) |      |      |       |   |

Notes:

- ① Repetitive rating;pulse width limited by max.junction temperature(see figure 11)
- ② L = 4mH, IAS = 14A, VDD = 50V,  
RG = 27Ω, Starting TJ = 25°C

③ I<sub>SD</sub>≤14A,di/dt≤250A/μ S,V<sub>DD</sub>≤V<sub>(BR)DSS</sub>,  
T<sub>J</sub>≤25°C

④ Pulse width≤300 μ S; duty cycle≤2%